

# **Exploration and Improvement of Material Analysis Technique Using Auger Electron Diffraction (AED)**

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# Research Motivation

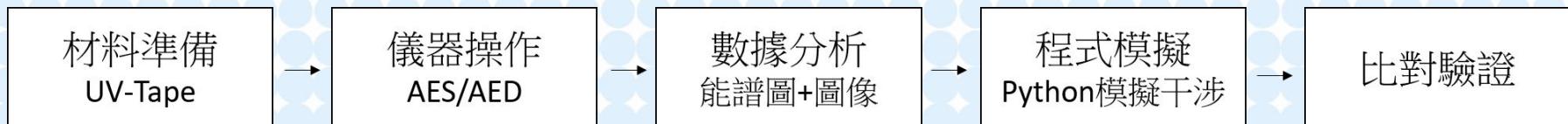
- In freshman year, we learned about the concept of **wave–particle duality**, which describes how electrons are not only particles but can also behave like waves, producing interference and diffraction. We wondered: *Is it possible to directly observe the wave nature of electrons?*
- We discovered that **electron diffraction techniques** are used in material analysis to observe this phenomenon. Our goal was to perform an experiment to see whether we could detect electron wave behavior ourselves.
- To observe diffraction patterns, we first needed a material thin enough for electrons to penetrate. We chose a widely used **two-dimensional material—molybdenum disulfide ( $\text{MoS}_2$ )**—and began by studying how to prepare high-quality samples.

# Research Objectives

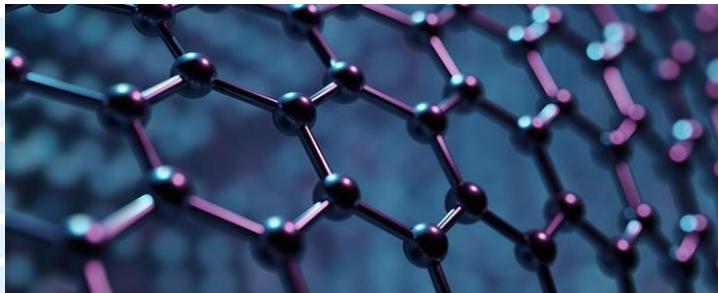
1. Prepare two-dimensional material samples suitable for analysis.
2. Conduct complete material analysis using **AED (Auger Electron Diffraction)**.
3. Build a **Python simulation model**.
4. Compare the simulated results with experimental data to verify the wave nature of electrons.

# Research Methods

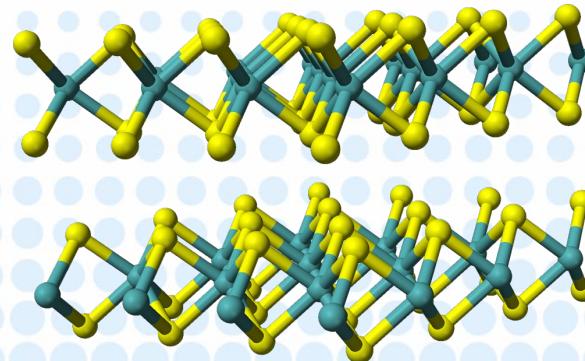
1. **Sample Preparation** – MoS<sub>2</sub> layers were exfoliated using **UV tape**.
2. **Experimental Analysis** – We conducted **AES/AED** experiments for energy spectrum and diffraction analysis.
3. **Computational Simulation** – A **Python program** was developed to simulate interference and diffraction patterns.



# Choice of Two-Dimensional Materials



Graphene

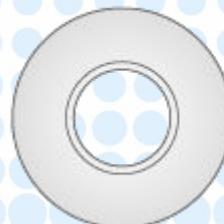


Molybdenum Disulfide(MoS<sub>2</sub>)

# How to Obtain Monolayer MoS<sub>2</sub>?



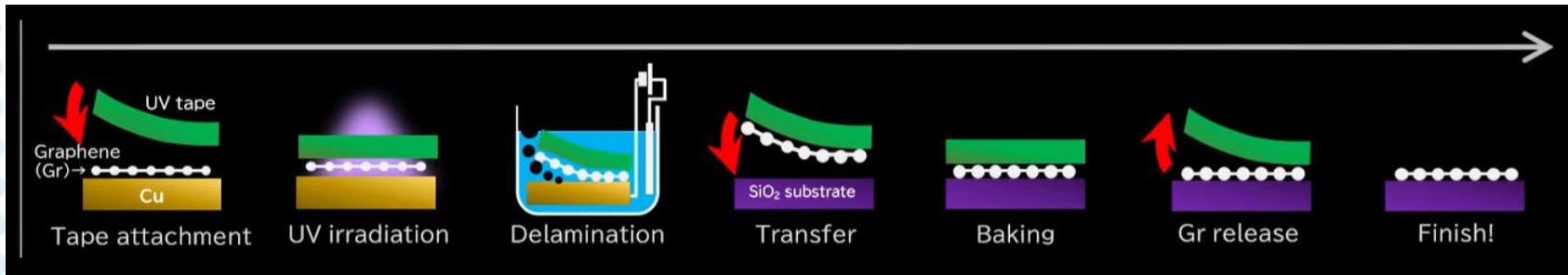
Regular tape



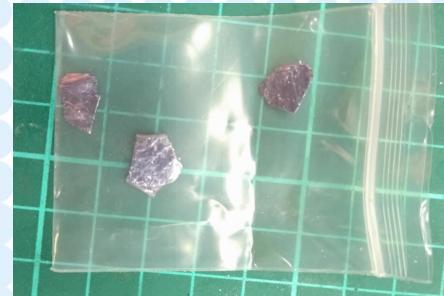
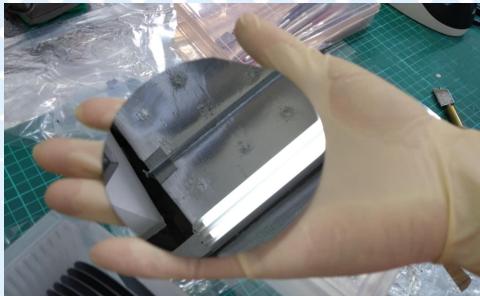
UV Tape Detackified tape



# MoS<sub>2</sub> Sample Preparation

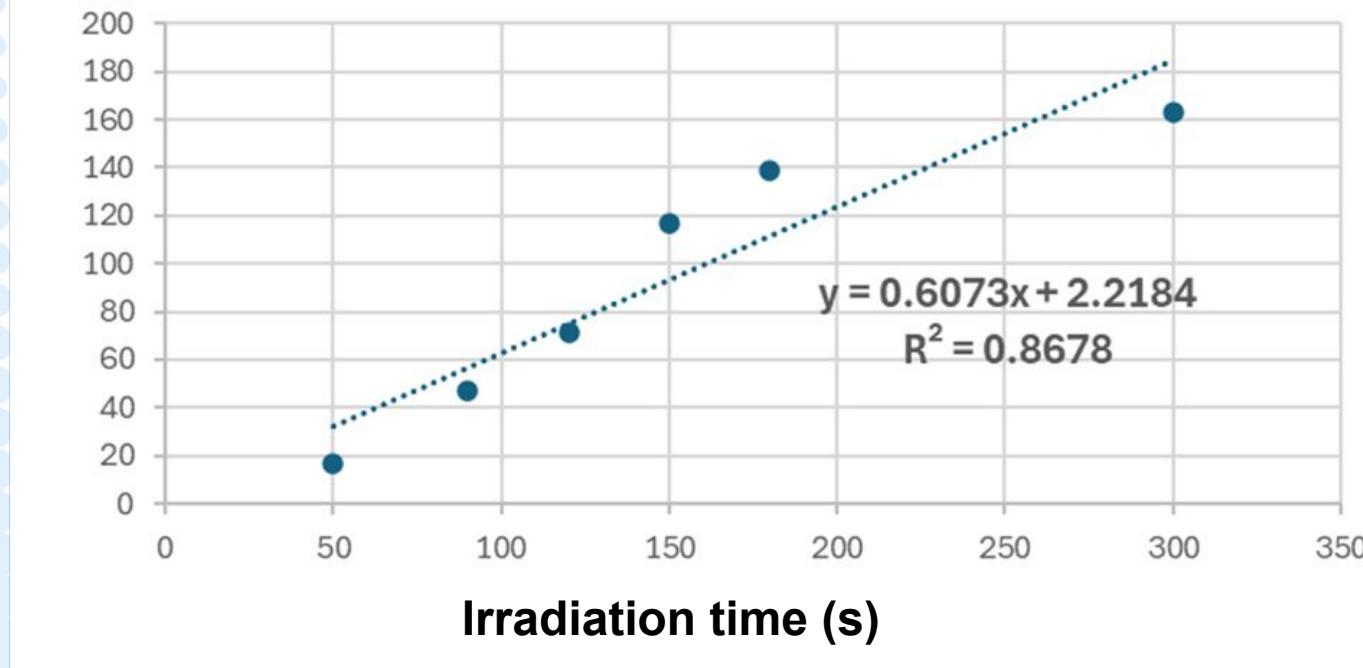


Monolayer MoS<sub>2</sub> Exfoliation Process (Using UV Tape)



# Experimental variables

Peeling area ( $\text{cm}^2$ )



# Process of exfoliating MoS<sub>2</sub> using UV tape



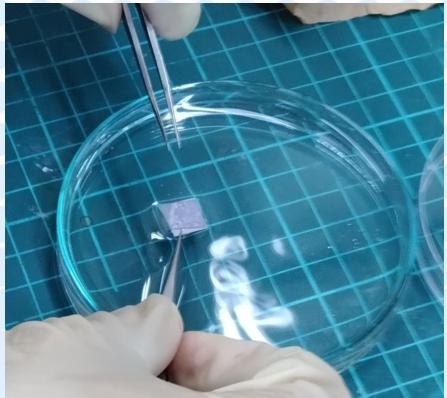
Cutting Silicon

Washing Silicon

Repeat Taping  
MoS<sub>2</sub>

Counter-Sticking Taping with UV-Tape

# Process of exfoliating MoS<sub>2</sub> using UV tape



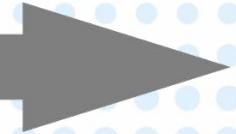
Transfer to Silicon



Irradiate with  
UV-Light

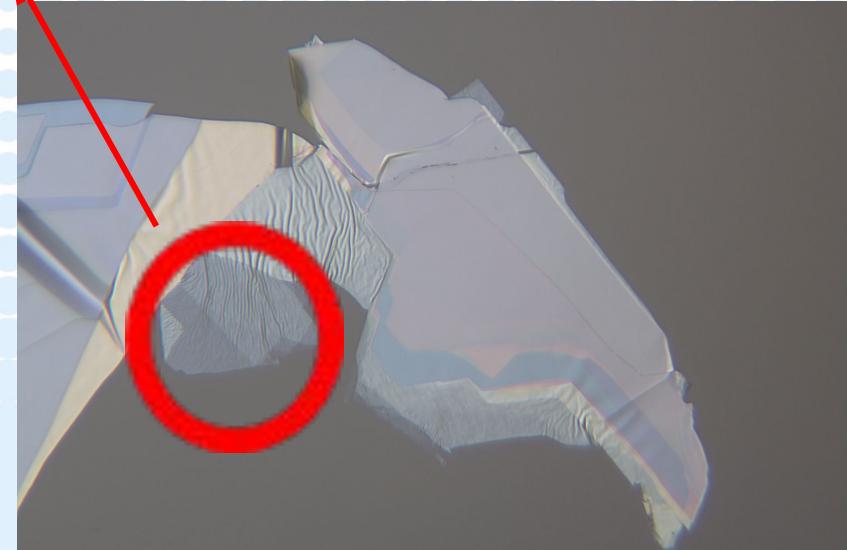
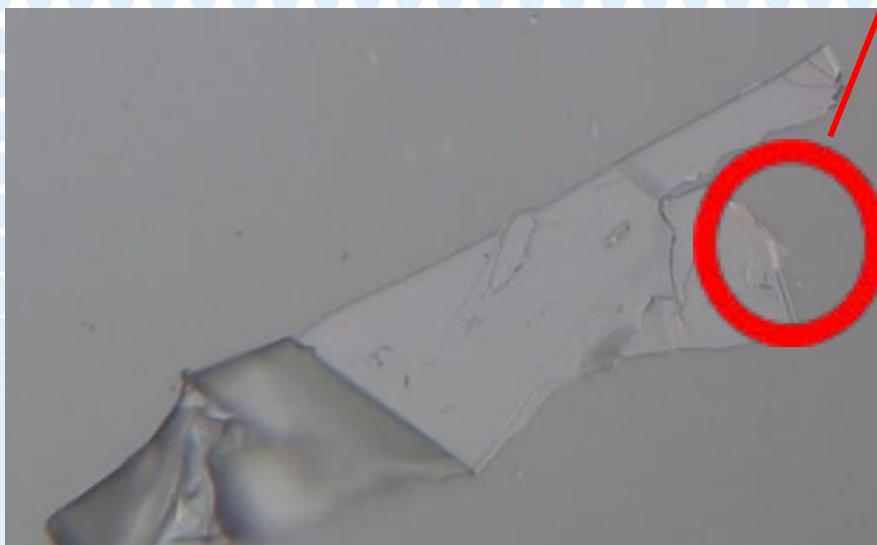


Observing with OM

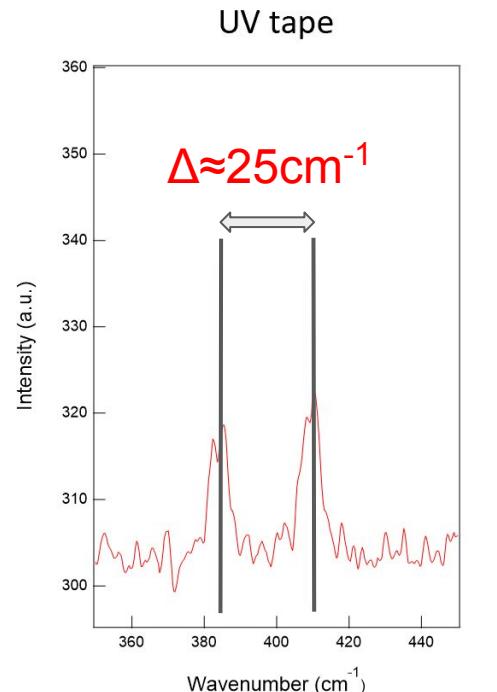


# Experimental Result

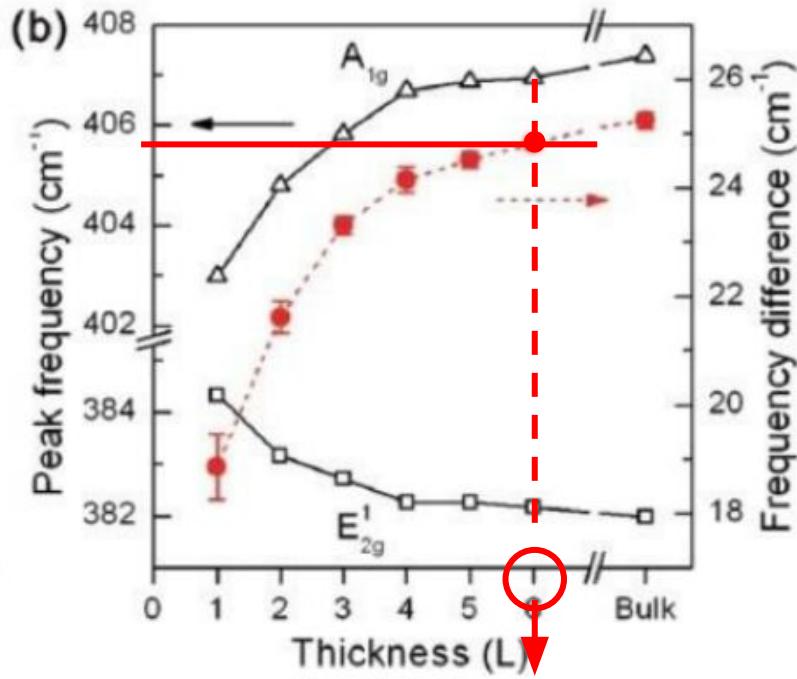
Monolayer MoS<sub>2</sub>



# How to confirm a monolayer?



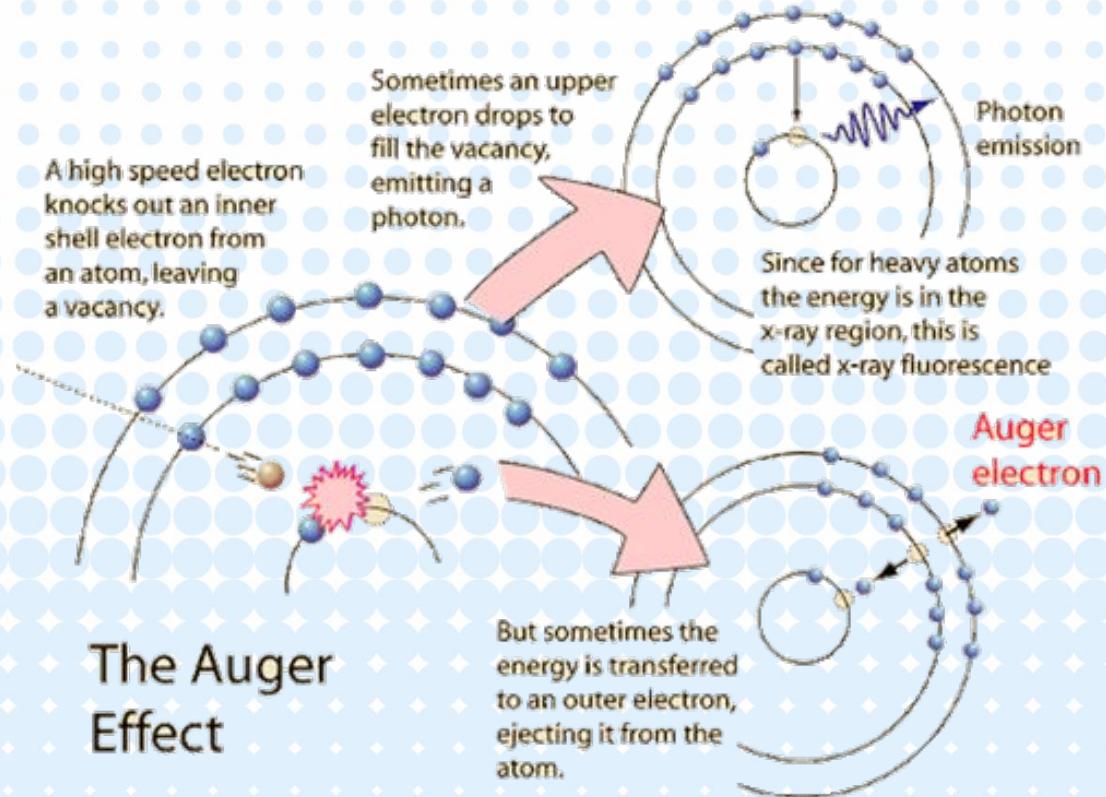
Raman spectroscopy data



Multilayer

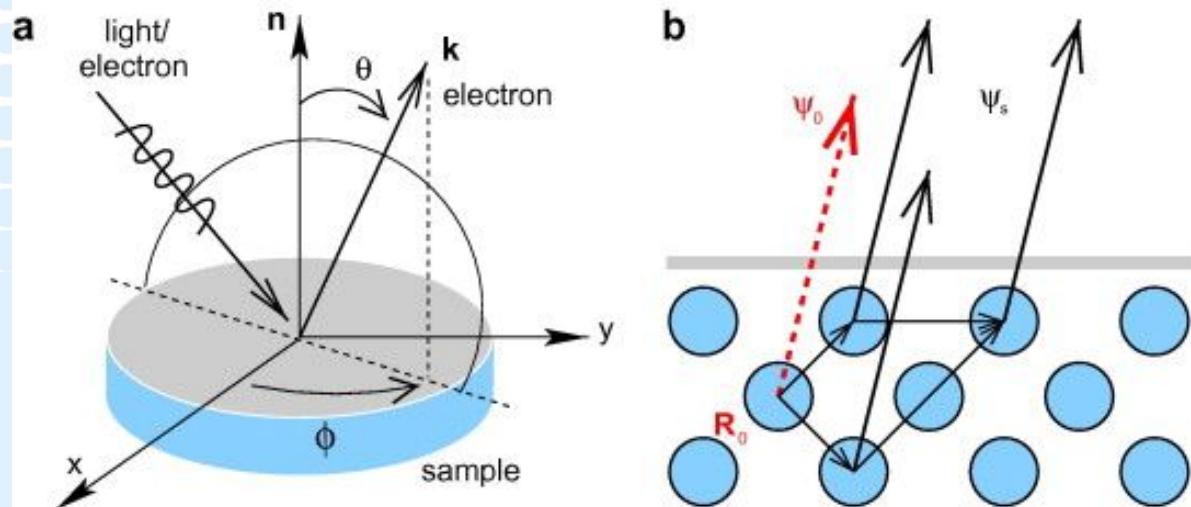
# What is AES? Auger Electron Spectroscopy

- **Auger Effect**
- By measuring the energy distribution of Auger electrons, one can determine the elements and their quantities present on the surface of a sample.



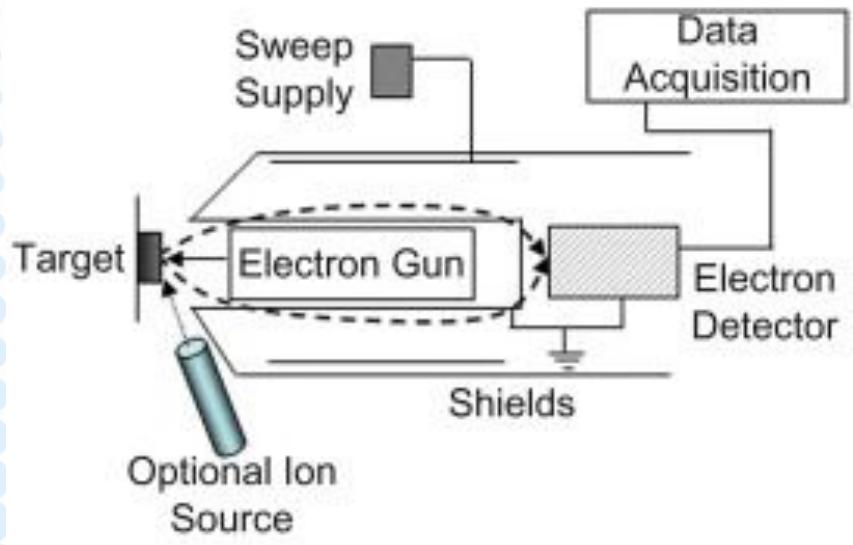
# What is AED? Auger Electron Diffraction

- In addition to measuring the energy distribution of Auger electrons, AED observes the interference and diffraction patterns produced by these electrons.
- Since Auger electrons emitted in different directions generate different patterns, AED can be used to determine the atomic arrangement on a material's surface.



# Structure of the AES

- Electron gun
- Vacuum system
- Energy analyzer
- Detector (DLD + MCP)
- Ion sputtering gun



# Introduction to AED/AES Material Analysis Techniques

Spectrum:

(1) The x-axis represents **kinetic energy**, and the y-axis represents **intensity**.

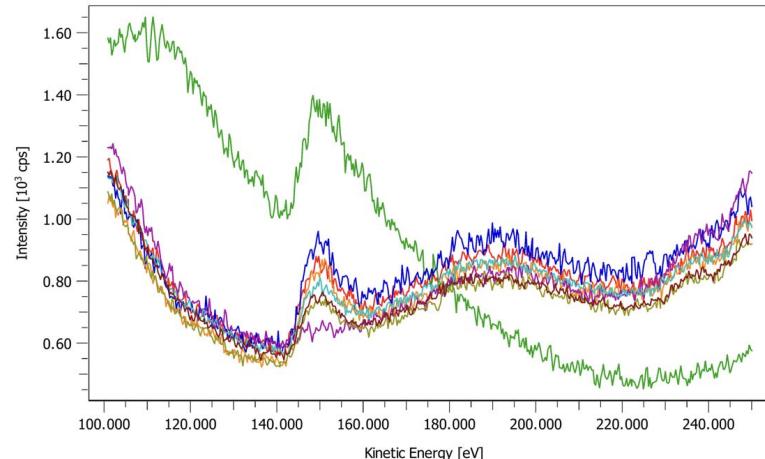
(2) Each Auger peak corresponds to the **Auger electron energy** of a different element.

SPECS™

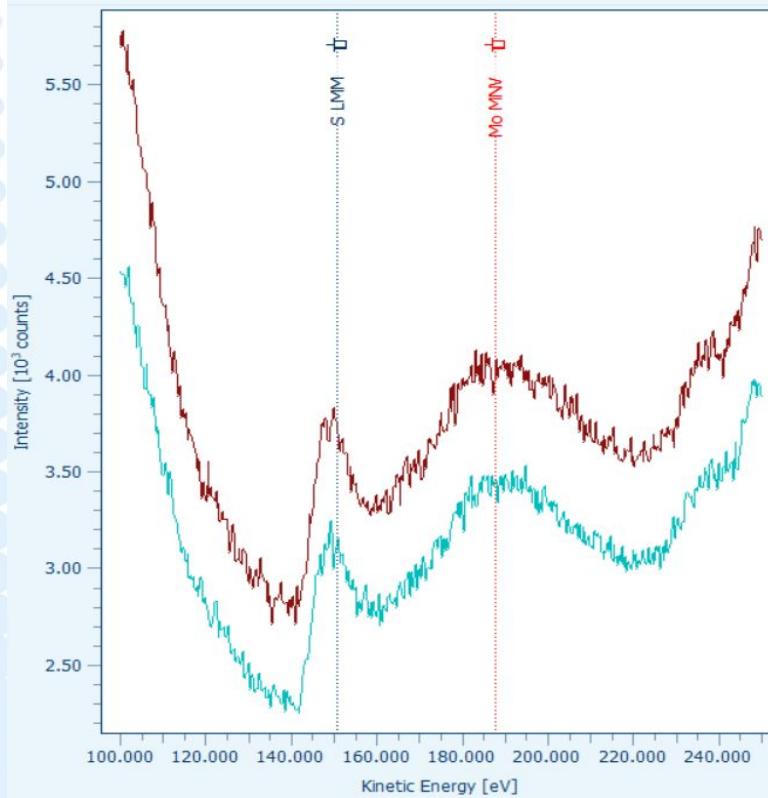
2025-03-06 MoS<sub>2</sub> Auger peak

## Spectrum Group

Method: AES, Slit: /, Mode: Fixed Analyzer Transmission,  
Excitation Energy: 0.00 eV, Detector Voltage: 2100 V, Bias Voltage: 0.00 V

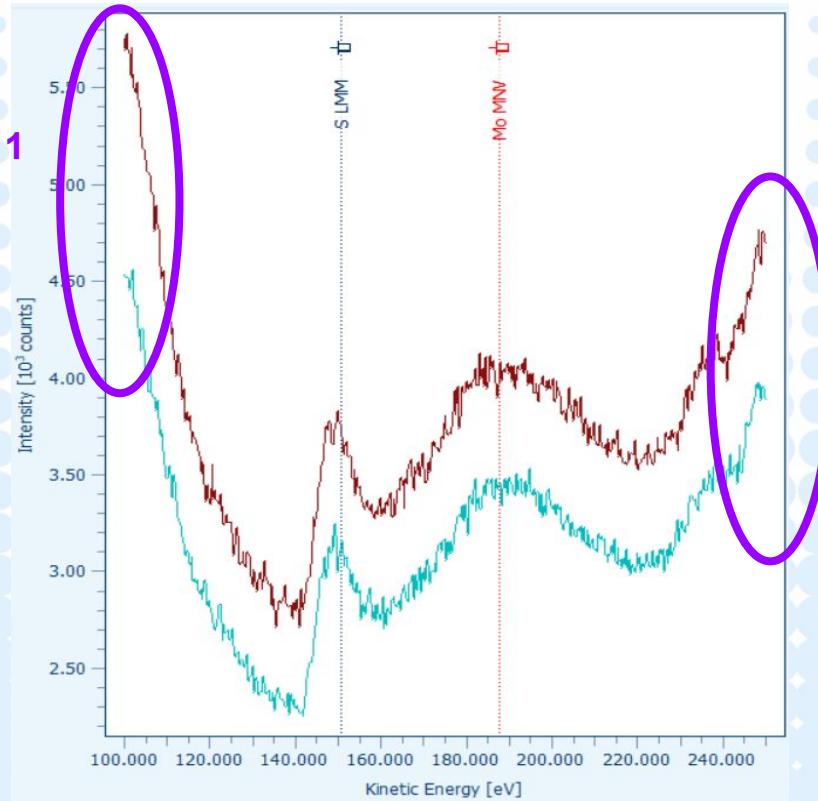


# Introduction to AED/AES Material Analysis Techniques



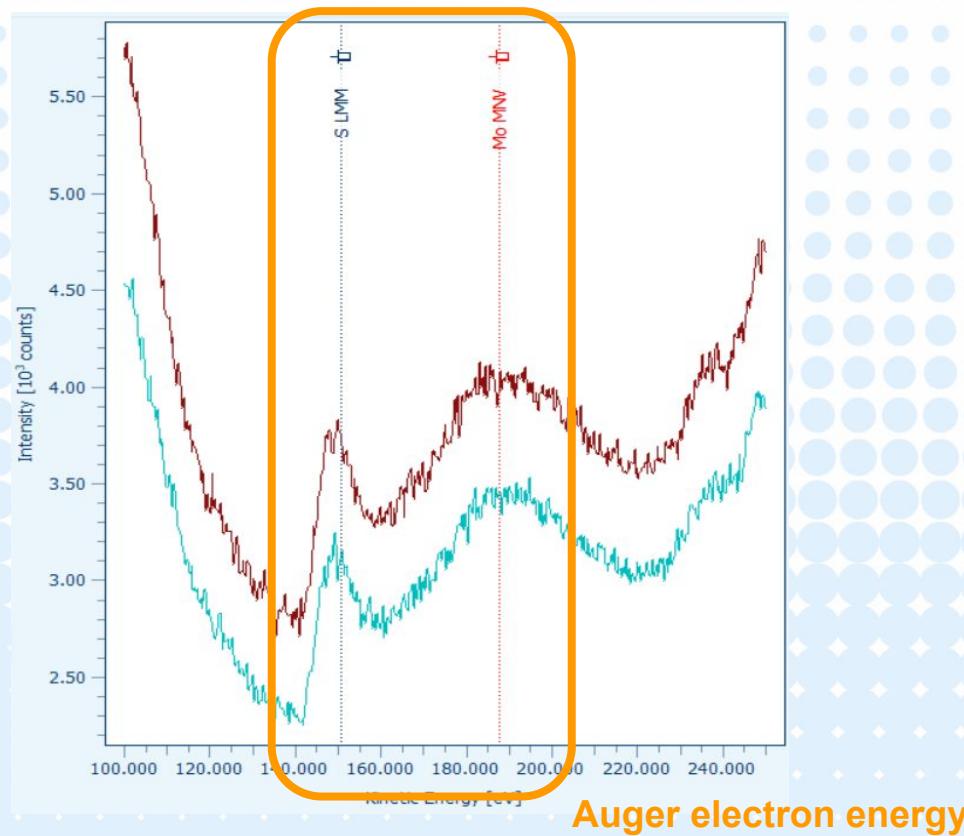
# Introduction to AED/AES Material Analysis Techniques

Photoelectron  
energy — Shell 1



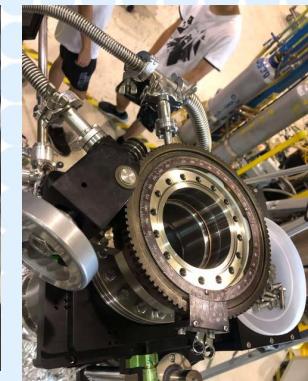
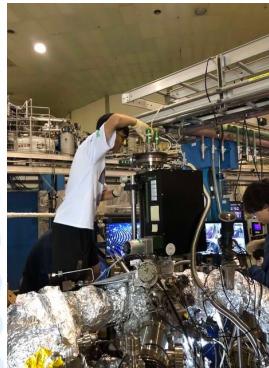
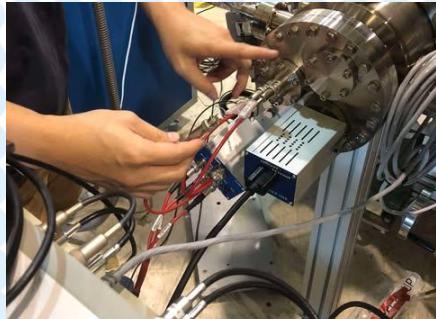
Photoelectron  
energy — Shell 2

# Introduction to AED/AES Material Analysis Techniques



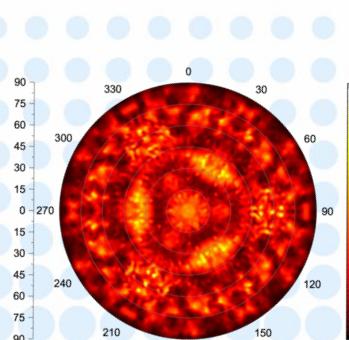
# Challenges: Instrument Malfunction and Repair

- *Time-of-flight* function failure
- Checked control panel and reconnected circuits
- Replaced damaged copper sample tube
- Restored the instrument to a vacuum environment (repeated nitrogen purging and pumping)

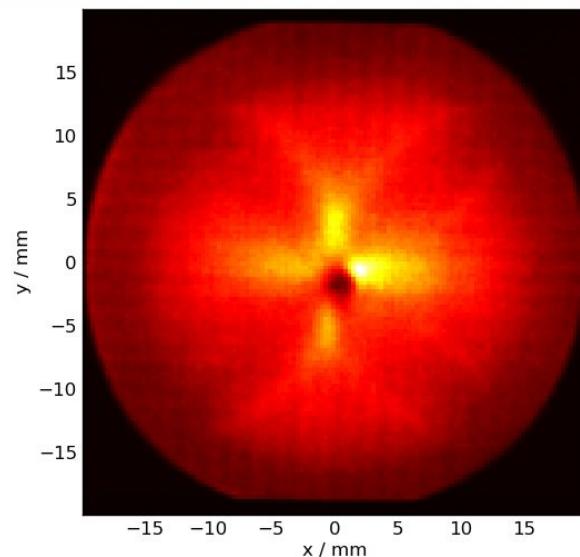


# AED Diffraction Patterns Obtained from Experiment

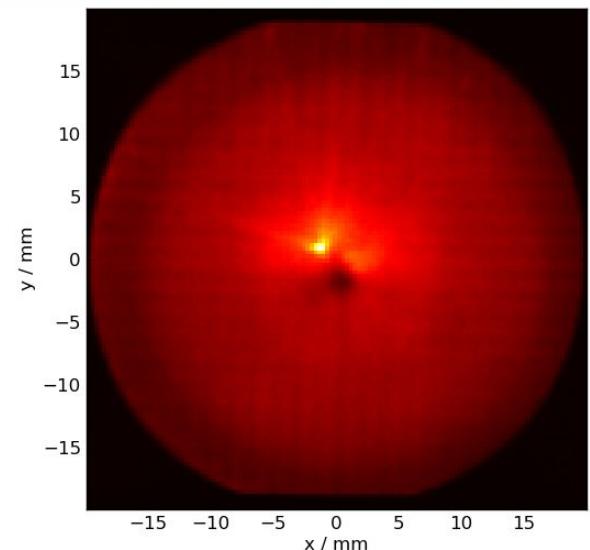
- Difficult to focus; diffraction patterns were unclear



Simulated Diffraction Pattern  
(CoO)



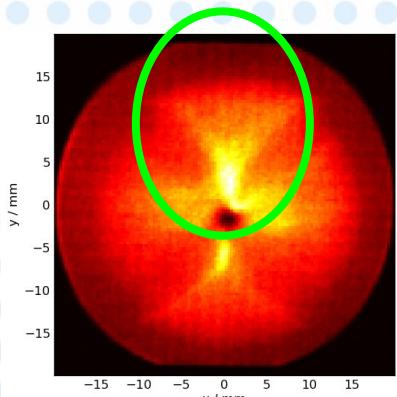
Early-stage diffraction pattern



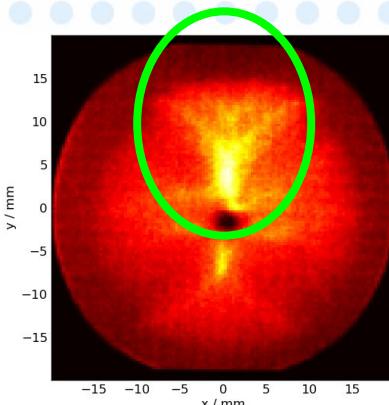
Late-stage diffraction pattern  
(Instrument declared out of order)

# AED Diffraction Patterns Obtained from Experiment

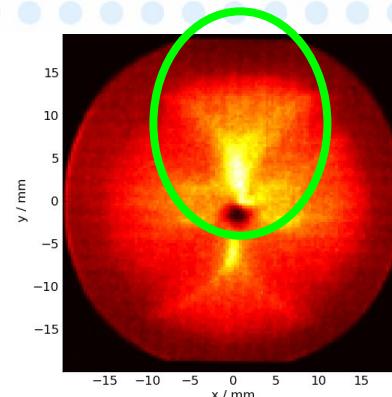
- At certain angles, differences can still be observed, indicating that the material has a specific directional arrangement.



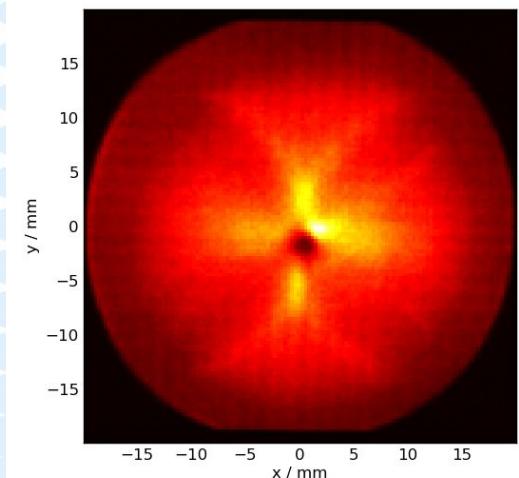
$45^\circ$



$225^\circ$



$315^\circ$



$0^\circ$  (and most other angles)

# Program simulation & tools

Category	Name	Purpose
Integrated development environment IDE	Spyder	Integrated development environment for coding and simulation
Programming language	Python	Write code
Package	ASE	Build molecular and crystal structures
Package	MsSpec	Simulate electron or electron diffraction patterns
Package	Matplotlib/NumPy	Create interference figures, perform numerical calculations



# Build atomic model and lattice structure

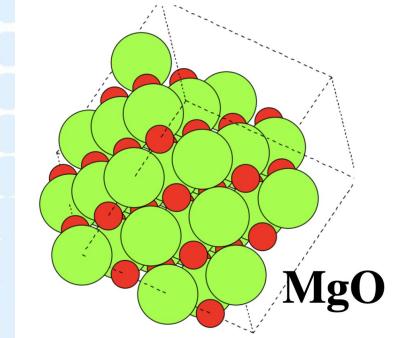
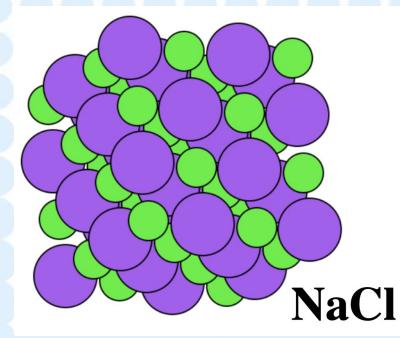
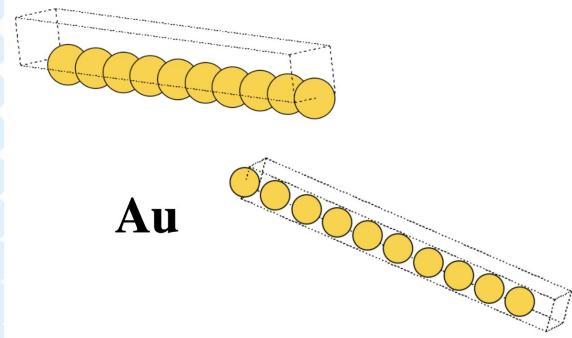
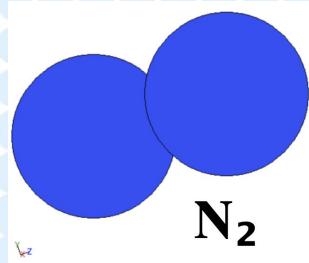
Simulations completed using the Atomic Simulation Environment (ASE) package

簡單氣體模型  
如  $\text{H}_2$ 、 $\text{O}_2$ 、 $\text{CO}_2$

金屬固體模型  
如 Cu、Al

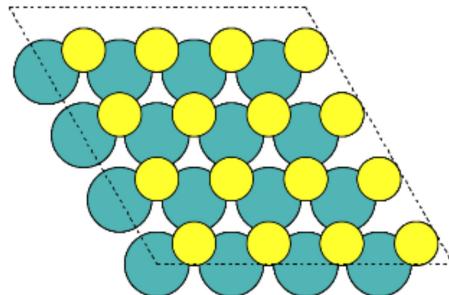
鹽類晶格模型  
如 NaCl、MgO

二硫化鉑模型  
 $\text{MoS}_2$ 過度金屬二硫族化合物

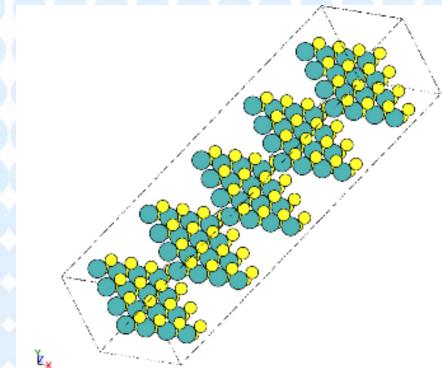


# Construct the MoS<sub>2</sub> model and verify the bond length

- Use the Bravais lattice framework + ASE's mx2() function
- Simulate 2H-phase MoS<sub>2</sub> with a diameter of 25 Å



MoS<sub>2</sub> Python model

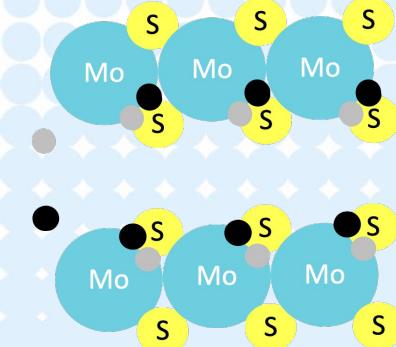


Calculate the average Mo–S bond length to validate the simulation accuracy:

Theoretical value – 2.4219 Å

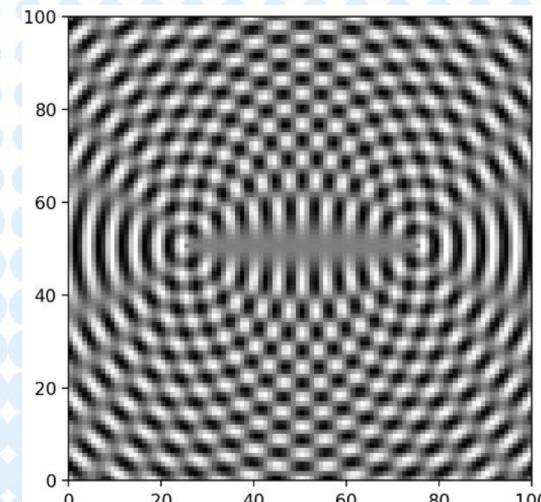
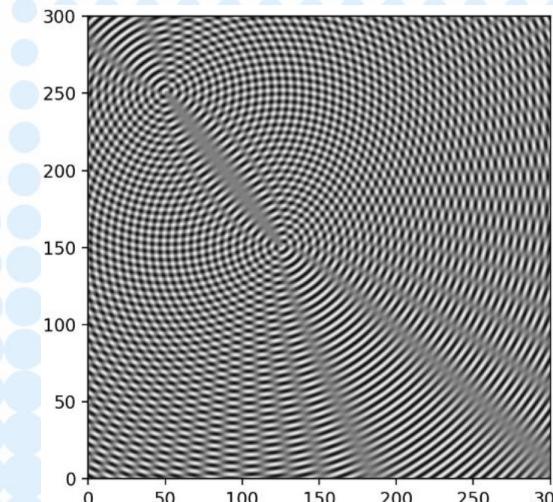
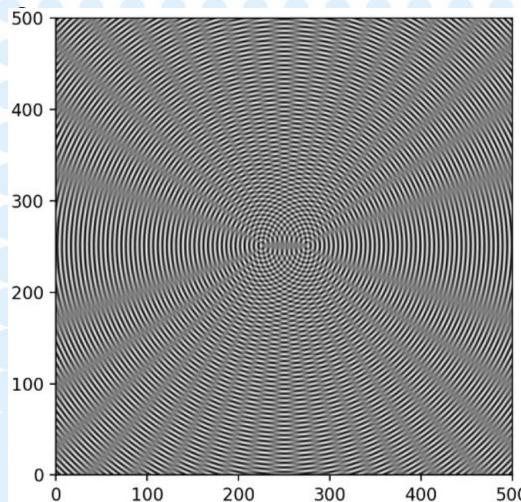
Calculated result – 2.4266 Å

Van De Waals bonds



# Simulating electron-wave interference and double-slit diffraction

- Simulate the superposition and cancellation of two wave sources in a 2D plane, and compute the total field value of the two sources on the plane.
- Use the imaging function `imshow()` with grayscale to display bright and dark fringes:



Simulated image of two-wave interference  
(adjusting source positions, resolution, and source spacing).

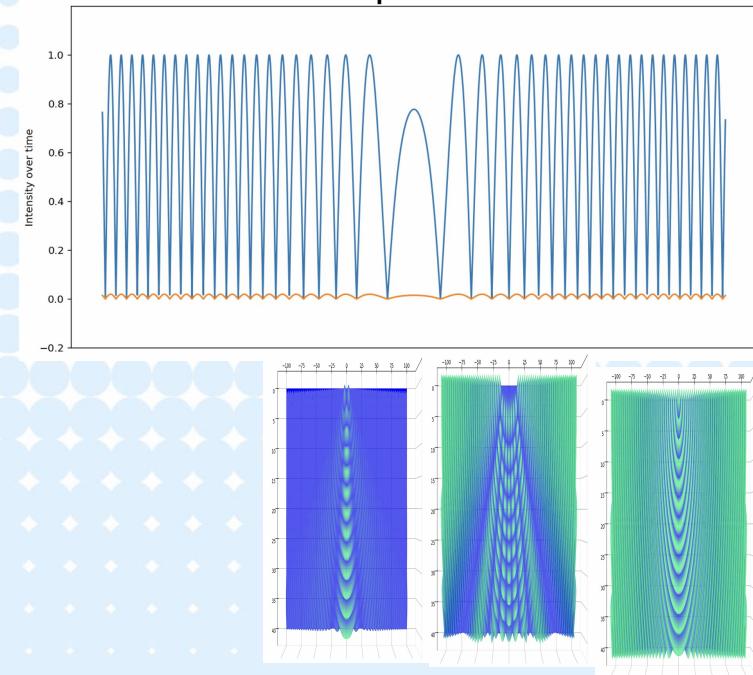
# Simulating electron-wave interference and double-slit diffraction

To simulate more complex wave states and compute the total field value, the waves are divided into four types:

類別	名稱(程式函數)	說明
1	single_wave	單一波源的波動傳播
2	single_slit_diffraction	單狹縫繞射
3	double_slit_no_diffraction	雙狹縫干涉但無繞射
4	double_slit_diffraction	雙狹縫干涉 + 繞射

Generate GIF images via `matplotlib.animation`.

Simulation of multiple-wave interference.

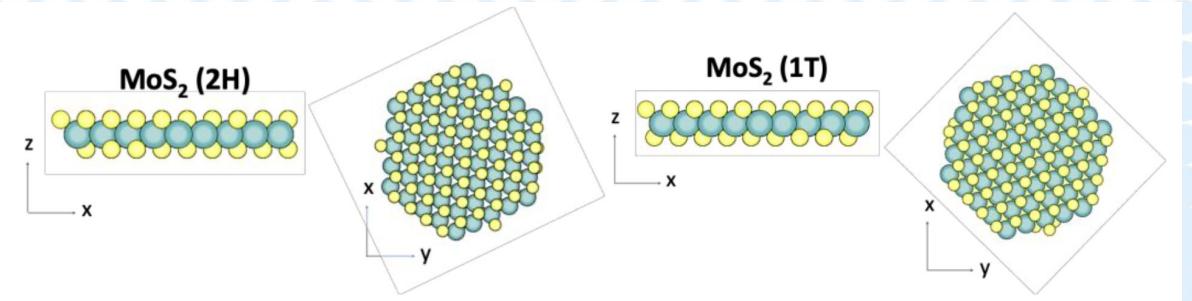


# MsSpec diffraction simulation: PED instead of AED

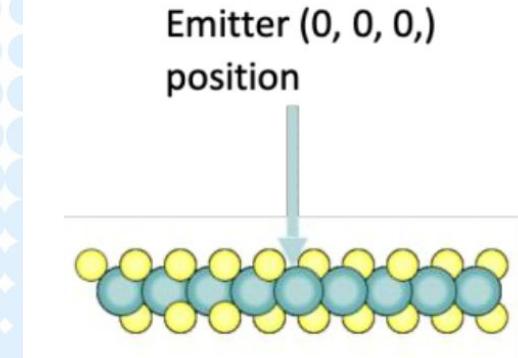
Using the MsSpec package, the Single Scattering Cluster (SSC) model is applied to simulate the spherical diffraction pattern of monolayer MoS<sub>2</sub>.



MsSpec1.0 Package



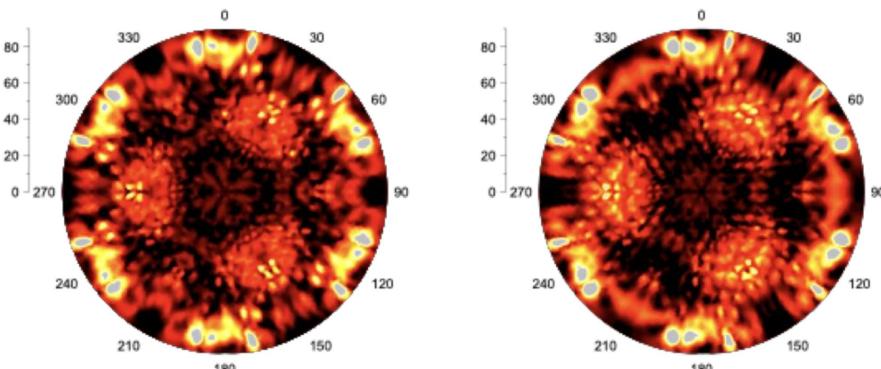
Lattice simulation of the 2H and 1T phases



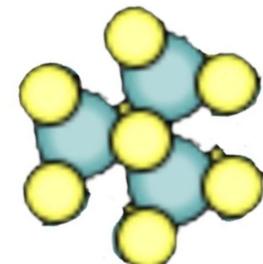
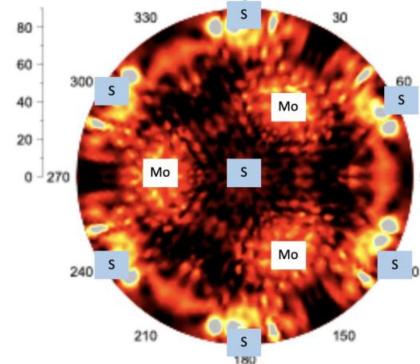
Schematic of incident electromagnetic-wave simulation (modeled with the 2H phase)

# Simulation Results

Using the `hemispherical_cluster()` function in the MsSpec package, a hemispherical atomic arrangement model was employed to predict diffraction patterns in all directions, simulating the diffraction of high-energy electromagnetic waves on a monolayer of molybdenum disulfide ( $\text{MoS}_2$ ).



The **left image** shows the simulated diffraction pattern of  $\text{MoS}_2$  in the **2H phase**, while the **right image** corresponds to the **1T phase**.



Elemental structures corresponding to the  $\text{MoS}_2$  diffraction patterns

# Conclusion

## Achieved

- Successfully simulated atomic structures and electron interference/diffraction models using Python.

## To Be Completed

- Prepare material samples suitable for analysis (large-area, flat surfaces).
- Conduct a full AED material analysis using the prepared samples.
- Compare experimental data with simulated results.

# Future Outlook

## Improving Sample Materials

- Develop self-made UV tape and adjust its composition ratio.
- Replace the material with strontium calcium copper oxide ( $\text{SrCaCuO}$ ).

## Repeated Experimental Verification

- After instrument repair, repeat AES/AED experiments multiple times to collect more data.
- Verify the accuracy of experimental data through computational modeling.
- Integrate AI-assisted analysis to improve AED data recognition efficiency.
- Apply the technique to broader material analysis in the future.



# Conclusion & Acknowledgments

This research combined theory, experimentation, and simulation to deeply explore the applications of quantum physics. Although we encountered many difficulties and challenges throughout the process, these experiences allowed us to truly understand the obstacles that real scientists often face in their work.

During this project, we received valuable guidance from professors at the National Synchrotron Radiation Research Center, who also provided us with opportunities to access advanced experimental instruments.

We would like to express our special thanks to Senior Student Liao Ze-Ming, who patiently assisted and instructed us in every experiment. His mentorship greatly enhanced our understanding of quantum physics and deepened our passion for the subject.

**Thanks for listening!**